Notice of References Cited Application/Control No. 10/695,201 Examiner Kyle M. Riddle Applicant(s)/Patent Under Reexamination TAKENAKA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,955,330	09-1990	Fabi et al.	123/90.17
*	В	US-6,561,149	05-2003	Kobayashi et al.	123/90.17
*	С	US-6,672,264	01-2004	Watanabe et al.	123/90.17
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	н	US-			
	_	US-			
	J	US-			
	К	US-			. 44
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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